

## DESCRIPTION

XD54563 is an eight-circuit output-sourcing Darlington transistor array. The circuits are made of PNP and NPN transistors. This semiconductor integrated circuit performs high-current driving with extremely low input-current supply.

## FEATURES

- High breakdown voltage ( $BV_{CEO} \geq 50V$ )
- High-current driving ( $I_o(\max) = -500mA$ )
- With clamping diodes
- Driving available with PMOS IC output of 6 ~ 16V or with TTL output
- Wide operating temperature range ( $T_a = -20$  to  $+75^{\circ}C$ )
- Output current-sourcing type

## APPLICATION

Drives of relays, printers, LEDs, fluorescent display tubes and lamps, and interfaces between MOS-bipolar logic systems and relays, solenoids, or small motors

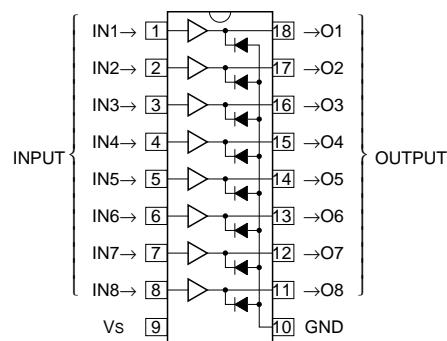
## FUNCTION

The XD54563 each have eight circuits, which are made of input inverters and current-sourcing outputs. The outputs are made of PNP transistors and NPN Darlington transistors. The PNP transistor base current is constant. A clamping diode is provided between each output and GND. Vs and GND are used commonly among the eight circuits.

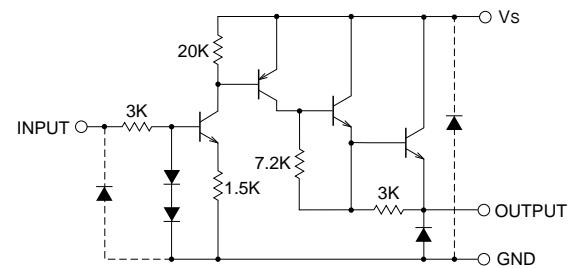
The inputs have resistance of  $3k\Omega$ , and voltage of up to 10V is applicable. Output current is 500 mA maximum. Supply voltage Vs is 50V maximum.

The XD54563 is enclosed in a molded small flat package, enabling space-saving design.

## PIN CONFIGURATION



## CIRCUIT DIAGRAM



The eight circuits share the Vs and GND.

The diode, indicated with the dotted line, is parasitic, and cannot be used.

Unit :  $\Omega$

# XD54563 DIP-18

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## **ABSOLUTE MAXIMUM RATINGS** (Unless otherwise noted, $T_a = -20 \sim +75^\circ\text{C}$ )

Symbol	Parameter	Conditions	Ratings	Unit
V <sub>CEO</sub> #	Collector-emitter voltage	Output, L	-0.5 ~ +50	V
V <sub>s</sub>	Supply voltage		50	V
V <sub>i</sub>	Input voltage		-0.5 ~ +10	V
I <sub>o</sub>	Output current	Current per circuit output, H	-500	mA
I <sub>F</sub>	Clamping diode forward current		-500	mA
V <sub>R</sub> #	Clamping diode reverse voltage		50	V
P <sub>d</sub>	Power dissipation	$T_a = 25^\circ\text{C}$ , when mounted on board	1.79(P)/1.10(FP)	W
T <sub>opr</sub>	Operating temperature		-20 ~ +75	°C
T <sub>tsg</sub>	Storage temperature		-55 ~ +125	°C

# : Unused I/O pins must be connected to GND.

## **RECOMMENDED OPERATING CONDITIONS** (Unless otherwise noted, $T_a = -20 \sim +75^\circ\text{C}$ )

Symbol	Parameter	Limits			Unit
		min	typ	max	
V <sub>s</sub>	Supply voltage	0	—	50	V
I <sub>o</sub>	Output current (Current per 1 circuit when 8 circuits are coming on simultaneously)	Duty Cycle P : no more than 8% FP : no more than 5%	0	—	-350
		Duty Cycle P : no more than 55% FP : no more than 30%	0	—	-100
V <sub>IH</sub>	"H" input voltage	2.4	—	10	V
V <sub>IL</sub>	"L" input voltage	0	—	0.2	V

## **ELECTRICAL CHARACTERISTICS** (Unless otherwise noted, $T_a = -20 \sim +75^\circ\text{C}$ )

Symbol	Parameter	Test conditions	Limits			Unit
			min	typ*	max	
I <sub>S</sub> (leak) #	Supply leak current	V <sub>s</sub> = 50V, V <sub>i</sub> = 0.2V	—	—	100	µA
V <sub>C E</sub> (sat)	Collector-emitter saturation voltage	V <sub>s</sub> = 10V, V <sub>i</sub> = 2.4V, I <sub>o</sub> = -350mA	—	1.6	2.4	V
		V <sub>s</sub> = 10V, V <sub>i</sub> = 2.4V, I <sub>o</sub> = -100mA	—	1.45	2.0	
I <sub>i</sub>	Input current	V <sub>i</sub> = 3V	—	0.6	1.0	mA
		V <sub>i</sub> = 10V	—	2.9	5.0	
I <sub>S</sub>	Supply current	V <sub>s</sub> = 50V, V <sub>i</sub> = 3V (all input)	—	5.6	15.0	mA
V <sub>F</sub>	Clamping diode forward voltage	I <sub>F</sub> = -350mA	—	-1.2	-2.4	V
I <sub>R</sub> #	Clamping diode reverse current	V <sub>R</sub> = 50V	—	—	100	µA

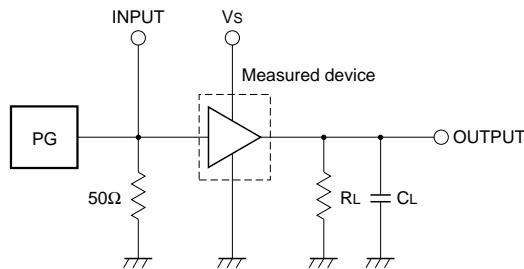
\* : The typical values are those measured under ambient temperature ( $T_a$ ) of  $25^\circ\text{C}$ . There is no guarantee that these values are obtained under any conditions.

# : Unused I/O pins must be connected to GND.

## **SWITCHING CHARACTERISTICS** (Unless otherwise noted, $T_a = 25^\circ\text{C}$ )

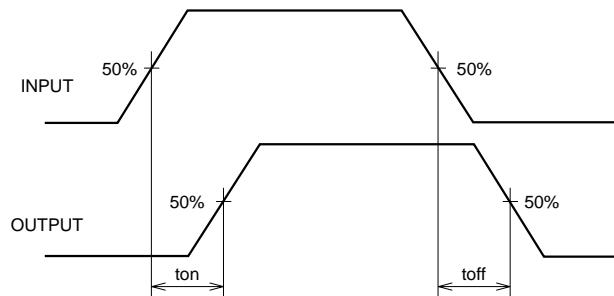
Symbol	Parameter	Test conditions	Limits			Unit
			min	typ	max	
t <sub>on</sub>	Turn-on time		—	100	—	ns
t <sub>off</sub>	Turn-off time	C <sub>L</sub> = 15pF (note 1)	—	4800	—	ns

## NOTE 1 TEST CIRCUIT

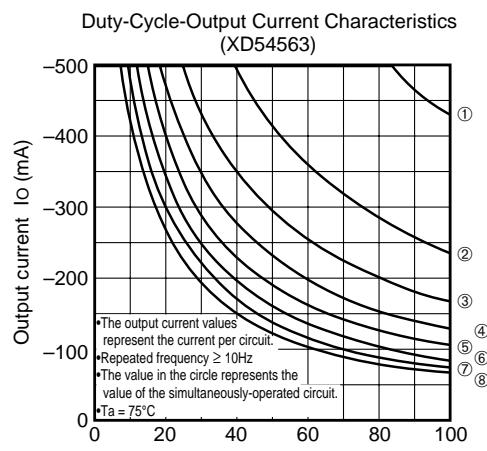
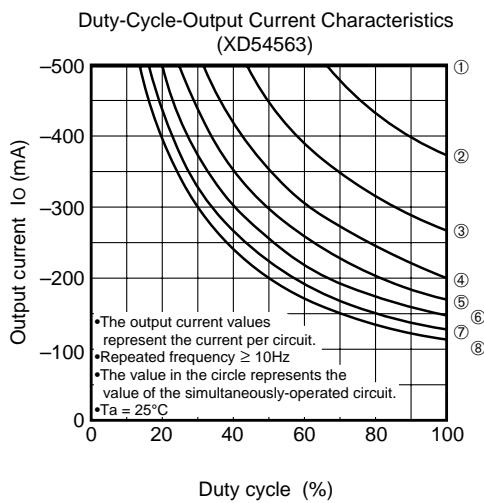
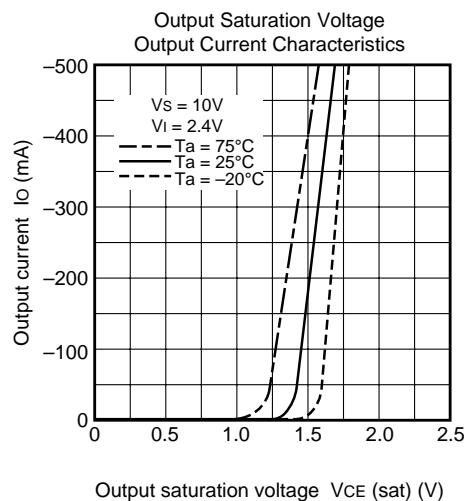
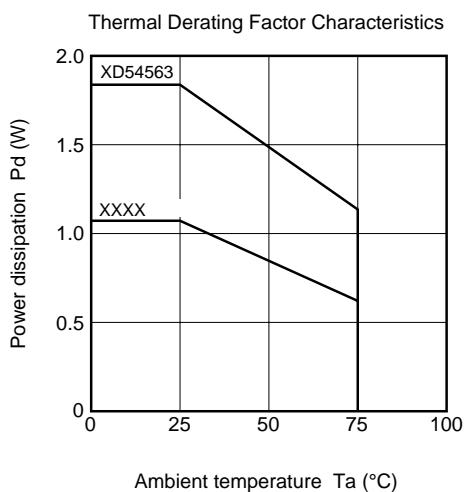


- (1) Pulse generator (PG) characteristics : PRR = 1kHz,  
 $t_w = 10\mu s$ ,  $t_r = 6ns$ ,  $t_f = 6ns$ ,  $Z_0 = 50\Omega$   
 $V_i = 0$  to  $2.4V$
- (2) Input-output conditions :  $R_L = 30\Omega$ ,  $V_s = 10V$
- (3) Electrostatic capacity  $C_L$  includes floating capacitance at connections and input capacitance at probes

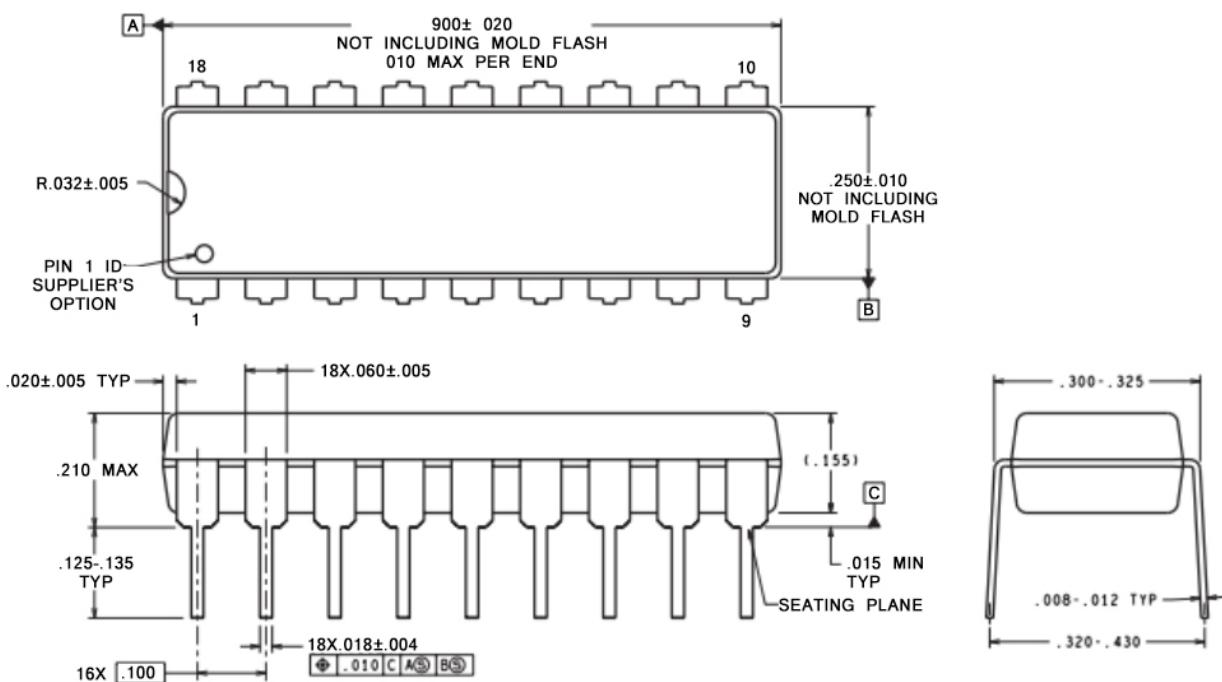
## TIMING DIAGRAM



## TYPICAL CHARACTERISTICS



DIP



以上信息仅供参考. 如需帮助联系客服人员。谢谢 XINLUDA